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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: 2823  
Examiner: William D. Coleman

In Re PATENT APPLICATION of:

Applicant(s) : Shigeyuki UEDA )

Serial No. : 09/665,663 )

Filed : September 20, 2000 )

For: SEMICONDUCTOR CHIP AND METHOD OF  
PRODUCING THE SAME )

Attorney Ref. : AI 281 )

**INFORMATION DISCLOSURE  
STATEMENT**

Mail Stop: Issue Fee  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(d) after Notice of Allowance, but before payment of the Issue Fee. As required by 37 C.F.R. §1.97(e)(1), it is certified that each item submitted with this Information Disclosure Statement was first cited in an Office Action from the Japanese Patent Office in a counterpart foreign application on February 3, 2004, that is, less than three months prior to filing this Information Disclosure Statement.

Attached are copies of the two Japanese patent publications cited therein. The relevance of the publications can be gleaned from the attached English language translations. The documents are listed on the attached Form PTO-1449. Also enclosed is the applicable fee of \$180.00 required by 37 C.F.R. §1.17(p).

Consideration of the submitted documents is respectfully requested.

Respectfully submitted,

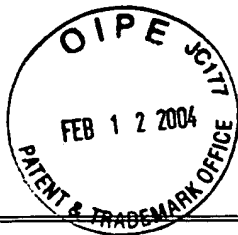
Steven M. Rabin - Reg. No. 29,102  
RABIN & BERDO, P.C.  
Telephone: (202) 371-8976  
Telefax: (202) 408-0924  
CUSTOMER NO. 23995

FEE ENCLOSED: \$ 180.  
Please charge any further  
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No. 18-00000034

February 12, 2004  
Date

SMR:tlc

02/17/2004 WABRHM1 00000034 09665663 180.00 DP  
01 FC:1806



<b>FORM PTO-1449</b> <b>INFORMATION DISCLOSURE STATEMENT</b>				Atty. Docket		Application No.	
				AI 281		09/899,819	
				Applicant Shigeyuki UEDA			
				Filing Date September 20, 2000		Group 2823	
<b>U.S. PATENT DOCUMENTS</b>							
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
<b>FOREIGN PATENT DOCUMENTS</b>							
		Document Number	Date	Country	Class	Sub-Class	Translation
	AI	11-121509	4/30/99	JAPAN			Yes
	AJ	11-135714	5/21/99	JAPAN			Yes
	AK						
	AL						
	AM						
	AN						
<b>OTHER (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AO						
Examiner					Date Considered		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							